

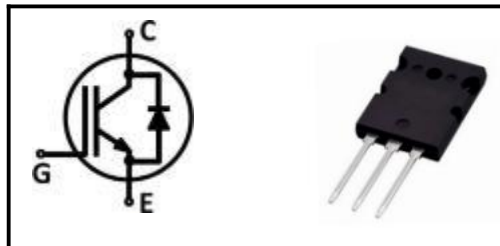
特征/Features

- 饱和压降为正温度系数，易于并联使用
Easy parallel switching capability due to positive temperature coefficient in V_{CEsat}
- 内置快速恢复二极管
Built-in fast recovery diode
- 高可靠性及热稳定性，良好的参数一致性
High reliability and thermal stability, good parameter consistency

应用领域/Applications

- 太阳能逆变器/Solar Inverter
- 焊接机/Welding Machine
- 不间断电源/UPS
- 功率因数校正/PFC
- PTC加热器/PTC heater
- 气候压缩机Climate compressor

型号/Type	打标/Marking	封装/Package
QML40N120E	QM40N120E	TO-264



最大额定值/Maximum Rated Values

Item	Symbol	Value	Unit
集电极-发射极电压 Collector-emitter voltage	V_{CE}	1200	V
集电极电流 DC collector current, limited by T_{vjmax} $T_C=25^\circ C$ $T_C=130^\circ C$	I_C	80 40	A
集电极脉冲电流 Pulsed collector current, t_p limited by T_{jmax1}	I_{Cpuls}	160	
二极管正向电流 Diode forward current, limited by T_{jmax} $T_C=25^\circ C$ $T_C=100^\circ C$	I_F	80 40	
二极管脉冲电流 Diode pulsed current, t_p limited by T_{jmax1}	I_{Fpuls}	160	
栅极-发射极电压 Gate-emitter voltage	V_{GE}	± 20	V
瞬态栅极-发射极电压 Transient Gate-emitter voltage ($t_p \leq 10\mu s, D < 0.01$)		± 30	
耗散功率 Power dissipation $T_C=25^\circ C$ $T_C=100^\circ C$	P_{tot}	428	W
		214	
工作结温 Operating junction temperature	T_j	-40~175	°C
储存温度 Storage temperature	T_{stg}	-55~150	
焊接温度 Soldering temperature, wave soldering 1.6mm (0.063in.) from case for 10s		260	
安装扭矩, M3 螺钉最大安装过程: 3 Mounting torque, M3 screw Maximum of mounting processes: 3	M	0.6	Nm

1) Defined by design. Not subject to production test.

电学特性/Electrical Characteristics

静态特性/Static Characteristics (at $T_j=25^\circ\text{C}$ unless otherwise specified)

Item	Symbol	Conditions	Min.	Typ.	Max.	Unit
集电极-发射极击穿电压 Collector-emitter breakdown voltage	$V_{(BR)CES}$	$V_{GE}=0V$, $I_C=0.25mA$	1200	-	-	V
集电极-发射极饱和电压 Collector-emitter saturation voltage	$V_{CE(sat)}$	$V_{GE}=15V$, $I_C=40A$ $T_j=25^\circ\text{C}$	-	1.7	2.0	
		$T_j=150^\circ\text{C}$	-	2.0	-	
		$T_j=175^\circ\text{C}$	-	2.1	-	
阈值电压 G-E threshold voltage	$V_{GE(th)}$	$I_C=1.5mA$, $V_{CE}=V_{GE}$	5.0	5.8	6.5	
集电极-发射极漏电流 C-E leakage current	I_{CES}	$V_{CE}=1200V$, $V_{GE}=0V$ $T_j=25^\circ\text{C}$	-	-	0.01	mA
		$T_j=175^\circ\text{C}$	-	-	4.0	
栅极-发射极漏电流 G-E leakage current	I_{GES}	$V_{CE}=0V$, $V_{GE}=20V$	-	-	250	nA

动态特性/Dynamic Characteristics

Item	Symbol	Conditions	Min.	Typ.	Max.	Unit
输入电容 Input capacitance	C_{iss}	$V_{CE}=25V$, $V_{GE}=0V$, $f=1MHz$	-	9900	-	pF
输出电容 Output capacitance	C_{oss}		-	102	-	
反馈电容 Reverse transfer capacitance	C_{rss}		-	102	-	
栅电荷 Gate charge	Q_G	$V_{CC}=400V$, $I_C=40A$, $V_{GE}=15V$	-	467	-	nC

热学特性/Thermal Characteristics

Item	Symbol	Conditions	Min.	Typ.	Max.	Unit
结-外壳热阻 IGBT thermal resistance, junction-case	R_{thJC}	-	-	0.28	0.35	K/W
二极管结-外壳热阻 Diode thermal resistance, junction-case	R_{thJCD}	-	-	-	0.80	
结-环境热阻 Thermal Resistance, junction-ambient	R_{thJA}	-	-	-	40	

IGBT开关特性(感性负载) / IGBT Switching Characteristics

Item	Symbol	Conditions	Min.	Typ.	Max.	Unit	
开通延迟时间 Turn-on delay time	$t_{d(on)}$	$T_J=25^{\circ}C,$ $V_{CC}=600V,$ $I_C=40A,$ $V_{GE}=0/15V,$ $R_G=10\Omega,$ <i>Inductive load</i>	-	113	-	ns	
上升时间 Rise time	t_r		-	76	-		
关断延迟时间 Turn-off delay time	$t_{d(off)}$		-	738	-		
下降时间 Fall time	t_f			-	80	-	
开通损耗 Turn-on energy	E_{on}			-	2.56	-	mJ
关断损耗 Turn-off energy	E_{off}			-	2.13	-	
开关损耗 Total switching energy	E_{ts}			-	4.69	-	
开通延迟时间 Turn-on delay time	$t_{d(on)}$		$T_J=175^{\circ}C,$ $V_{CC}=600V,$ $I_C=40A,$ $V_{GE}=0/15V,$ $R_G=10\Omega,$ <i>Inductive load</i>	-	118	-	ns
上升时间 Rise time	t_r			-	54	-	
关断延迟时间 Turn-off delay time	$t_{d(off)}$	-		738	-		
下降时间 Fall time	t_f			-	162	-	
开通损耗 Turn-on energy	E_{on}			-	3.62	-	mJ
关断损耗 Turn-off energy	E_{off}			-	3.54	-	
开关损耗 Total switching energy	E_{ts}			-	7.16	-	

二极管开关特性/Diode Characteristics

Item	Symbol	Conditions	Min.	Typ.	Max.	Unit
二极管正向压降 Diode forward voltage	V_F	$V_{GE}=0V, I_F=40A$ $T_J=25^{\circ}C$	-	2.4	3.0	V
		$T_J=150^{\circ}C$	-	2.1	-	
		$T_J=175^{\circ}C$	-	2.0	-	
反向恢复时间 Diode reverse recovery time	t_{rr}	$T_J=25^{\circ}C,$ $V_R=400V,$ $I_F=40A,$ $di_F/dt=600A/\mu s$	-	165	-	ns
反向恢复电荷 Diode reverse recovery charge	Q_{rr}		-	1.49	-	μC
反向恢复峰值电流 Diode peak reverse recovery current	I_{rrm}		-	20.0	-	A
反向恢复时间 Diode reverse recovery time	t_{rr}	$T_J=150^{\circ}C,$ $V_R=400V,$ $I_F=40A,$ $di_F/dt=600A/\mu s$	-	286	-	ns
反向恢复电荷 Diode reverse recovery charge	Q_{rr}		-	3.52	-	μC
反向恢复峰值电流 Diode peak reverse recovery current	I_{rrm}		-	28.8	-	A

修订历史/Revision History:

修订 /Revision	主题（自上次修订以来的主要变化） /Subjects (major changes since last revision)	日期 /Date
1.0	Initial Version	2023-04

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